## Notice of References Cited

Ī	Application/Control No.	Applicant(s)/Pater	nt Under
	10/569,787	Reexamination HANAMURA ET	AL.
	Examiner	Art Unit	
	Christopher P. Schwartz	3683	Page 1 of 1

## U.S. PATENT DOCUMENTS

	U.S. I AILIN DOGGMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,231,555	11-1980	Saito, Tsutomu	267/154
*	В	US-5,491,996 A	02-1996	Baarman et al.	72/128
*	С	US-6,318,710 B1	11-2001	Anderson et al.	267/273
*	D	US-2002/0170177 A1	11-2002	Koyama et al.	29/897.2
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	Т	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

		NON-PATENT DOCUMENTS
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
Γ	v	
	w	
	×	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.